#### **General Description**

The SJD30N042 uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a wide variety of applications.

#### **Features**

- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

#### **Application**

- PWM Applications
- Load Switch
- Power Management

#### **Key Performance Parametes**

Parameter	Value	Unit
V <sub>DS</sub>	30	V
R <sub>DS(ON)_TYP</sub>	3.9	mΩ
I <sub>D</sub>	90	A
Q <sub>G</sub>	34	nC



#### **Package Marking and Ordering Information**

Device/Ordering Code	Marking	Package	Reel Size	Tape width	Quantity
SJD30N042	SJD30N042	TO-252	\	\	\

#### Table 1. Absolute Maximum Ratings (T<sub>C</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Limit	Unit
V <sub>DS</sub>	Drain-Source Voltage (V <sub>GS</sub> =0V)	30	V
V <sub>G</sub> S	Gate-Source Voltage (V <sub>DS</sub> =0V)	±20	V
I-	Drain Current-Continuous(T <sub>C</sub> =25°C)		А
I <sub>D</sub>	Drain Current-Continuous(Tc=100°C)	57	А
I <sub>DM</sub> (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	360	А
D-	Maximum Power Dissipation(Tc=25°C)	66	W
P <sub>D</sub>	Maximum Power Dissipation(T <sub>C</sub> =100°C)	26	W
Eas	Avalanche energy (Note 2)	169	mJ
TJ, TSTG	Operating Junction and Storage Temperature Range	-55 To 175	°C

#### Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case		1.9	°C/W

Table 3. Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off States						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	30			V
	7 0 1 1/4 5 1 0 1	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V T <sub>J</sub> =25°C			1	μA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V T <sub>J</sub> =125°C			100	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1		2.5	V
<b>g</b> FS	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A		24		S
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A T <sub>J</sub> =25°C		3.9	5.1	mΩ
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =15A T <sub>J</sub> =25°C		6	8	mΩ
Dynamic Charac	cteristics		I	I		I
Ciss	Input Capacitance			1760		pF
Coss	Output Capacitance	V <sub>DS</sub> =15V,V <sub>GS</sub> =0V, f=1.0MHz		193		pF
Crss	Reverse Transfer Capacitance			172		pF
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1.0MHz		1.6		Ω
Switching Parar	meters		I.	I		I
t <sub>d(on)</sub>	Turn-on Delay Time			7		nS
t <sub>r</sub>	Turn-on Rise Time	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V,		14		nS
$t_{d(off)}$	Turn-Off Delay Time	R <sub>L</sub> =0.75Ω, R <sub>GEN</sub> =6Ω		34		nS
t <sub>f</sub>	Turn-Off Fall Time			11		nS
$Q_g$	Total Gate Charge			34		nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A		6.5		nC
$Q_{gd}$	Gate-Drain Charge			7.5		nC
Source-Drain Di	ode Characteristics	'				
I <sub>SD</sub>	Source-Drain Current (Body Diode)				90	А
V <sub>SD</sub>	Forward on Voltage (Note 3)	V <sub>GS</sub> =0V, I <sub>S</sub> =20A			1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I=20A, dI/dt=100A/μs		10		ns
Qrr	Reverse Recovery Charge	I <sub>F</sub> =20A, dI/dt=100A/μs		1.7		nC
	1		1	1		

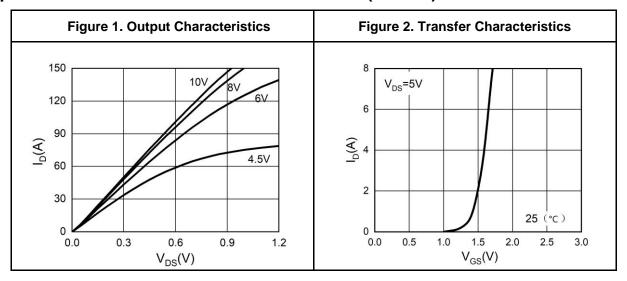
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

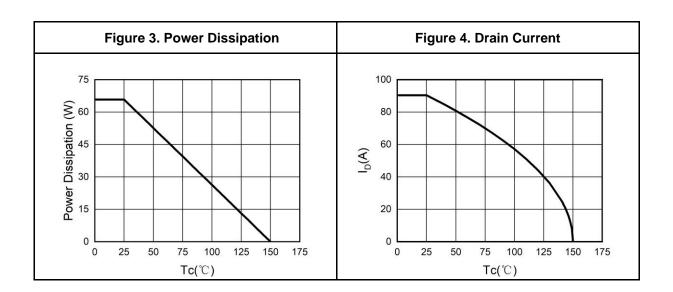
Notes 2.E<sub>AS</sub> condition:  $T_J=25^{\circ}C$ ,  $V_{DD}=30V$ ,  $V_G=10V$ ,  $Rg=25\Omega$ , L=0.5mH.

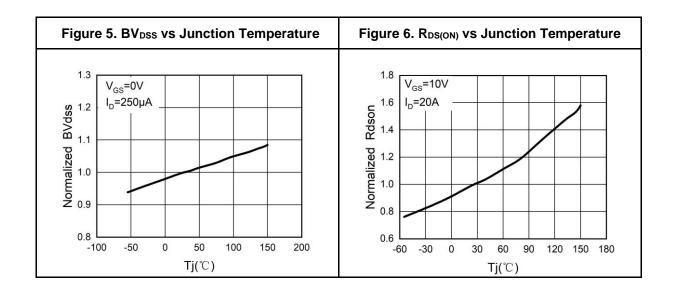
Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.



## **Typical Electrical And Thermal Characteristics (Curves)**

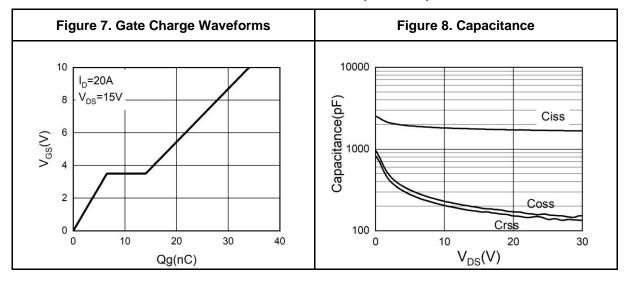


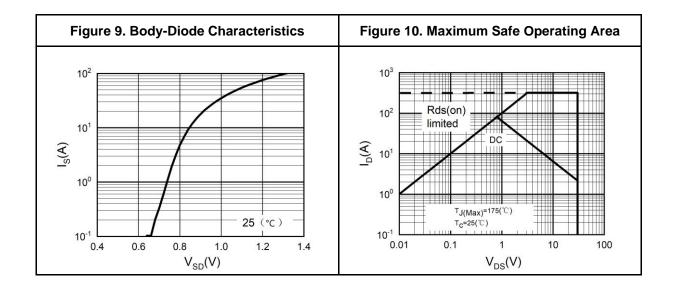






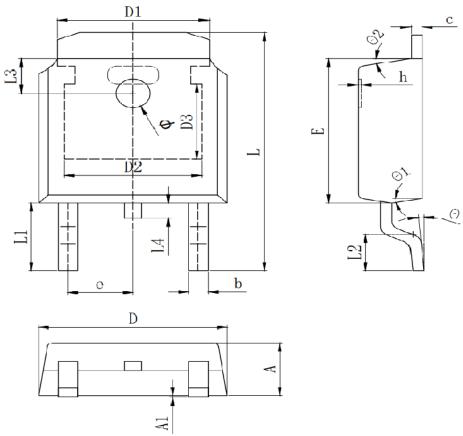
## **Typical Electrical And Thermal Characteristics (Curves)**







# **TO-252 Package Information**



Sumbal	Dimensions In Millimeters			
Symbol	Min.	Тур.	Max.	
А	2.200	2.300	2.400	
A1	0.000		0.127	
b	0.640	0.690	0.740	
c(电镀后)	0.460	0.520	0.580	
D	6.500	6.600	6.700	
D1		5.334 REF		
D2		4.826 REF		
D3		3.166 REF		
Е	6.000	6.100	6.200	
е		2.286 TYP		
h	0.000	0.100	0.200	
L	9.900	10.100	10.300	
L1		2.888 REF		
L2	1.400	1.550	1.700	
L3		1.600 REF		
L4	0.600 0.800		1.000	
Ф	1.100	1.200	1.300	
θ	0°		8°	
θ1	,	9° TYP	,	
θ2		9° TYP		

#### Attention

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi Shangjia Semiconductor.

The performances and characteristics of this product in the independent testing state are displayed in this document. Wuxi Shangjia Semiconductor can't guarantee of the performances and characteristics of this described product that mounted in the customer's products or equipments as same as that in the independent testing state. So the customer should evaluate and test devices mounted in the customer's products or equipments.

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